

# GCMX080A120B2H2P

## QSiC™ 1200V SiC Full-Bridge Module

$V_{DS}$	1200 V
$R_{DS,on}$	77 mΩ
$I_D (T_C=25^\circ C)$	27 A
$T_{J,max}$	175°C

### Features

- High speed switching SiC MOSFETs
- Reliable body diode
- All parts tested to above 1350V
- Kelvin reference for stable operation
- Press fit terminal connections
- Split DC negative terminals

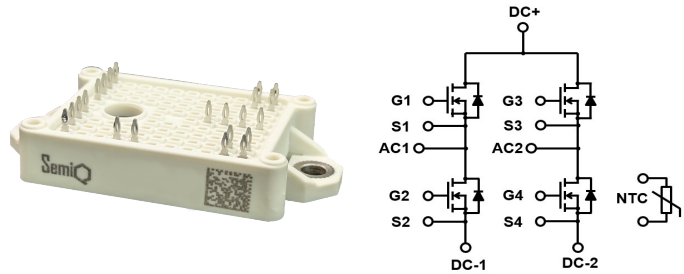
### Benefits

- Low switching losses
- Low junction to case thermal resistance
- Very rugged and easy mounting
- Direct mounting to heatsink (isolated package)

### Applications

- Photovoltaic Inverter
- Battery charger
- Energy storage system
- High voltage DC to DC converter

### Package



Part #	Package	Marking
GCMX080A120B2H2P	B2	GCMX080A120B2H2P



### Absolute Maximum Ratings, at $T_J=25^\circ C$ , unless otherwise specified

Characteristics	Symbol	Conditions	Values	Unit
Drain-Source Voltage	$V_{rated}$	$V_{GS}=0V, I_D=1\mu A$	1200	V
Continuous Drain Current	$I_{DS}$	$T_C=25^\circ C, V_{GS}=20V, T_J=175^\circ C$	27	A
		$T_C=65^\circ C, V_{GS}=20V, T_J=175^\circ C$	23	
Body Diode Drain Current	$I_{SD}$	$T_C=25^\circ C, V_{GS}=-5V, T_J=175^\circ C$	30	
Pulsed Drain Current	$I_{DS,pulse}$	$T_C=25^\circ C, V_{GS}=20V$	80	
Gate Source Voltage	$V_{GSmax}$		-10/25	V
	$V_{GSop}$	Recommended operational	-5/20	
Power Dissipation	$P_{tot}$	$T_C=25^\circ C, T_J=175^\circ C$	119	W
Junction Temperature	$T_J$	Continuous	-40...175	°C
Case & Storage Temperature	$T_C, T_{storage}$	Continuous	-40...150	°C

Static Electrical Characteristics, at T<sub>J</sub>=25°C, unless otherwise specified

Characteristics	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =1mA	1200	-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =1200V, V <sub>GS</sub> =0V	-	0.1	1	μA
		V <sub>DS</sub> =1200V, V <sub>GS</sub> =0V, T <sub>J</sub> =150°C	-	1	100	
Gate-Source Leakage Current	I <sub>GSS+</sub>	V <sub>GS</sub> =20V, V <sub>DS</sub> =0V	-	10	1000	nA
	I <sub>GSS-</sub>	V <sub>GS</sub> =-5V, V <sub>DS</sub> =0V	-	-10	-1000	
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =10mA	1.8	3.1	4	V
		V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =10mA, T <sub>J</sub> =150°C	-	2.2	-	
Drain-Source On-Resistance	R <sub>DSon</sub> *	V <sub>GS</sub> =20V, I <sub>D</sub> =20A	-	77	100	mΩ
		V <sub>GS</sub> =20V, I <sub>D</sub> =10A	-	71	-	
		V <sub>GS</sub> =20V, I <sub>D</sub> =20A, T <sub>J</sub> =150°C	-	130	-	
Transconductance	g <sub>fs</sub>	V <sub>DS</sub> =20V, I <sub>D</sub> =20A	-	8.3	-	S
		V <sub>DS</sub> =20V, I <sub>D</sub> =20A, T <sub>J</sub> =150°C	-	8.3	-	
Internal Gate Resistance	R <sub>G(int)</sub>	f=1MHz, V <sub>AC</sub> =25mV, D-S Short	-	3.1	-	Ω

\*R<sub>DSon</sub> including package resistance

AC Electrical Characteristics, at T<sub>J</sub>=25°C, unless otherwise specified

Characteristics	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> =0V	-	1.4	-	nF
Output Capacitance	C <sub>OSS</sub>	V <sub>DS</sub> =800V	-	0.15	-	
Reverse Transfer Capacitance	C <sub>RSS</sub>	f=200kHz	-	0.01	-	
Coss Stored Energy	E <sub>OSS</sub> **	Vac=25mV	-	55	-	μJ
Turn-On Switching Energy	E <sub>ON</sub>	T <sub>J</sub> =25°C	-	0.13	-	mJ
		T <sub>J</sub> =125°C	-	0.21	-	
		T <sub>J</sub> =150°C	-	0.23	-	
Turn-Off Switching Energy	E <sub>OFF</sub>	T <sub>J</sub> =25°C	-	0.04	-	
		T <sub>J</sub> =125°C	-	0.04	-	
		T <sub>J</sub> =150°C	-	0.04	-	
Turn-On Delay Time	t <sub>D(on)</sub>	V <sub>DD</sub> =600V, I <sub>DS</sub> =20A, R <sub>G(ext)</sub> =6.8Ω, V <sub>GS</sub> =-5V/20V, L=975μH	-	11	-	ns
Rise Time	t <sub>R</sub>		-	5	-	
Turn-Off Delay Time	t <sub>D(off)</sub>		-	22	-	
Fall Time	t <sub>F</sub>		-	12	-	
Total Gate Charge	Q <sub>G</sub>		-	58	-	
Gate to Source Charge	Q <sub>GS</sub>	V <sub>DD</sub> =800V, I <sub>DS</sub> =20A	-	21	-	nC
Gate to Drain Charge	Q <sub>GD</sub>	V <sub>GS</sub> =-5/20V	-	14	-	

\*\*E<sub>OSS</sub> is calculated from C<sub>OSS</sub> curve

# QSiC™ 1200V SiC Full-Bridge Module

# GCMX080A120B2H2P

Freewheeling Diode Characteristics, at  $T_J=25^\circ\text{C}$ , unless otherwise specified

Characteristics	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Diode Forward Voltage	$V_{SD}$	$V_{GS}=-5\text{V}, I_S=40\text{A}$	-	4.2	-	V
		$V_{GS}=-5\text{V}, I_S=40\text{A}, T_J=150^\circ\text{C}$	-	3.6	-	
Reverse Recovery Time	$t_{RR}$	$T_J=25^\circ\text{C}$ $I_S=20\text{A},$ $V_R=600\text{V},$ $V_{GS}=-5\text{V},$ $di/dt=5.4\text{A/ns}$	-	17	-	ns
Reverse Recovery Charge	$Q_{RR}$		-	116	-	nC
Peak Reverse Recovery Current	$I_{RRM}$		-	21	-	A
Reverse Recovery Energy	$E_{RR}$	$T_J=25^\circ\text{C}$	-	0.03	-	mJ
		$T_J=125^\circ\text{C}$	-	0.11	-	
		$T_J=150^\circ\text{C}$ $R_{G(\text{ext})} = 6.8\Omega$	-	0.13	-	

Thermal and Package Characteristics, at  $T_J=25^\circ\text{C}$ , unless otherwise specified

Characteristics	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Thermal resistance, junction-case	$R_{thJC}$		-	1.07	1.26	$^\circ\text{C/W}$
Mounting torque	$M_d$	M4-0.7 screws	-	2.00	2.3	N-m
Press fit pin PCB end hole diameter			0.99	-	1.09	mm
Press fit pin PCB hole drill diameter			1.12	1.15	-	mm
Press fit pin PCB hole copper thickness			25	-	50	$\mu\text{m}$
Package weight	$W_t$		-	40	-	g
Isolation voltage	$V_{ISOL}$	$I_{ISOL} < 1\text{mA}, 50/60\text{ Hz}, 1\text{ min}$	3000	-	-	V

NTC Characteristics, at  $T_J=25^\circ\text{C}$ , unless otherwise specified

Characteristics	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Rated resistance	$R_{NTC}$	$T_{NTC} = 25^\circ\text{C}$	-	5.0	-	k $\Omega$
Resistance tolerance	$\Delta R/R$		-5	-	5	%
Beta Value ( $T_2 = 50^\circ\text{C}$ )	$\beta_{25/50}$		-	3380	-	k
Beta Value ( $T_2 = 80^\circ\text{C}$ )	$\beta_{25/80}$		-	3440	-	k
Power dissipation	$P_{MAX}$	$T_{NTC} = 25^\circ\text{C}$	-	-	50	mW

Typical Performance

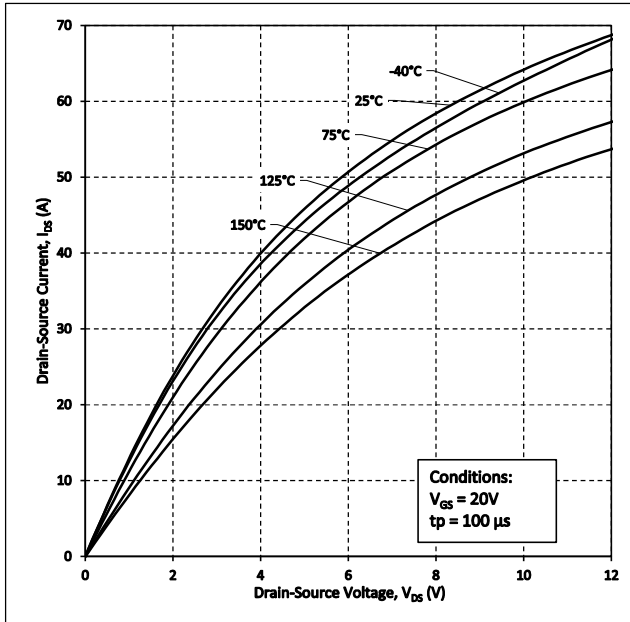


Figure 1. Output Characteristics for Various Temperatures

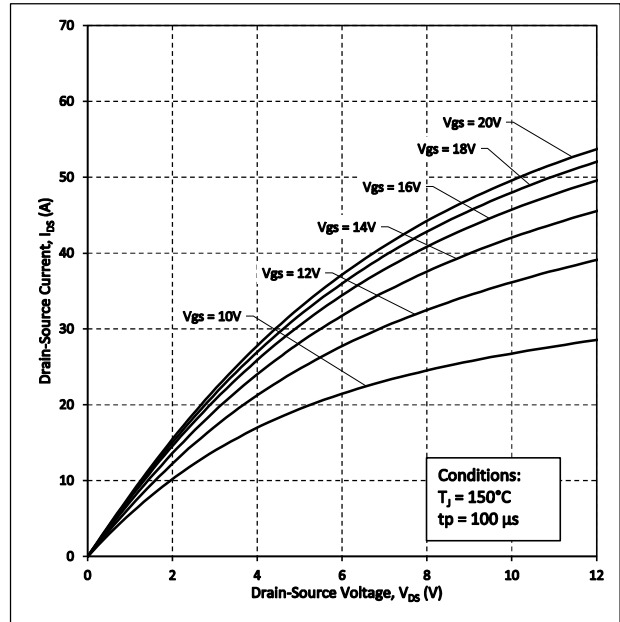


Figure 2. Output Characteristics  $T_J = 150^\circ C$

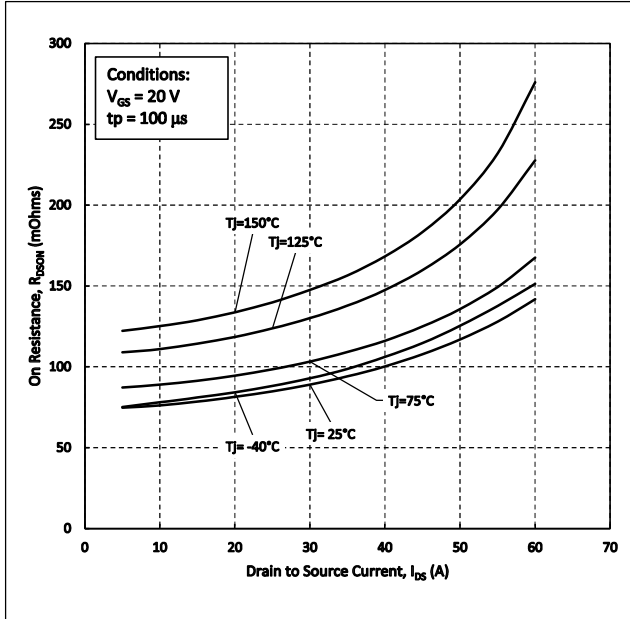


Figure 3. On-Resistance vs. Drain Current For Various Temperatures

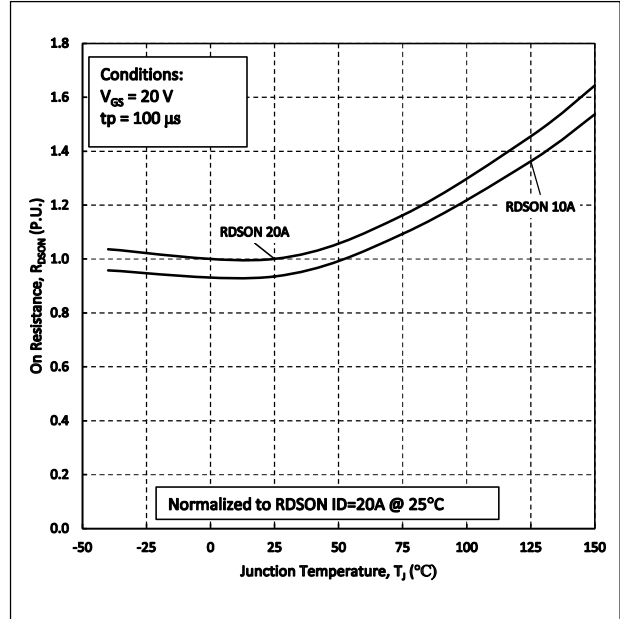


Figure 4. Normalized On-Resistance vs. Temperature

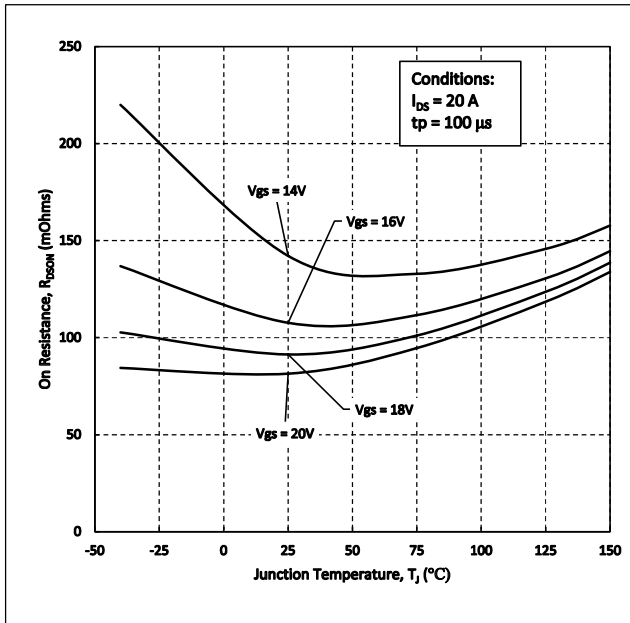


Figure 5. On-Resistance vs. Temperature For Various Gate Voltages

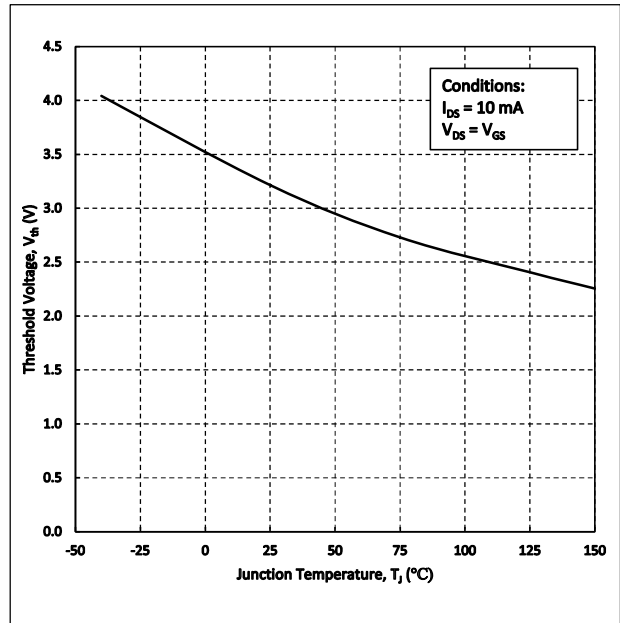


Figure 6. Threshold Voltage vs. Temperature

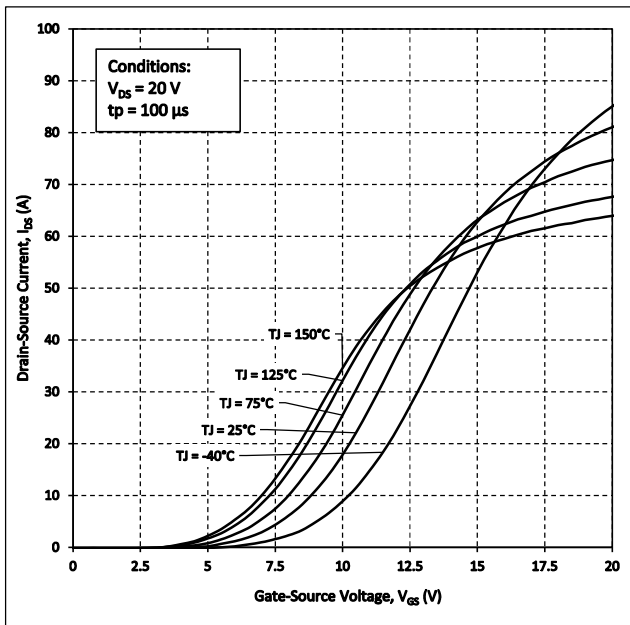


Figure 7. Transfer Characteristic for Various Junction Temperatures

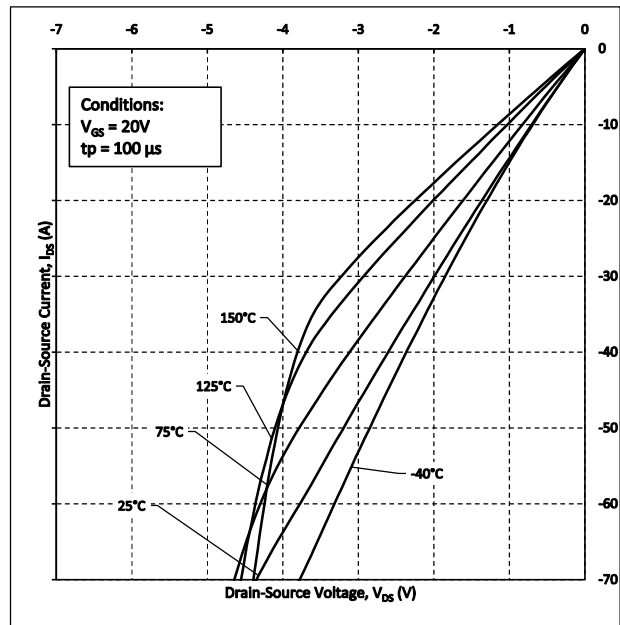


Figure 8. 3<sup>rd</sup> Quadrant Characteristics at V<sub>GS</sub> = 20V

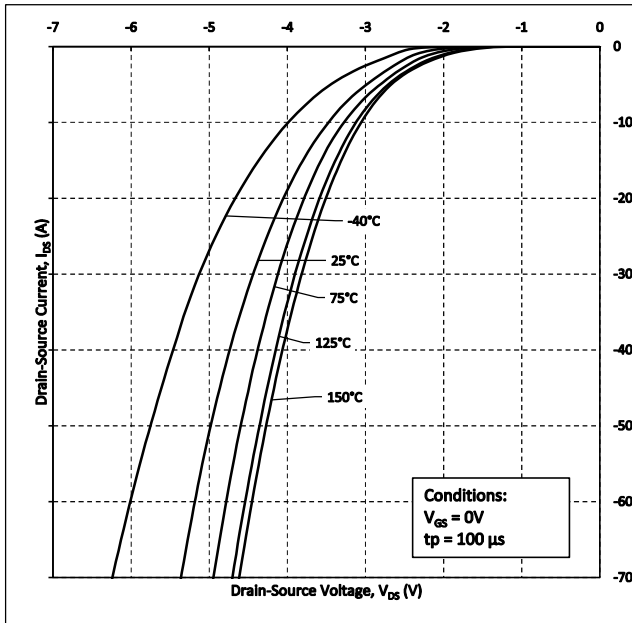


Figure 9. Body Diode Characteristics at  $V_{GS} = 0V$

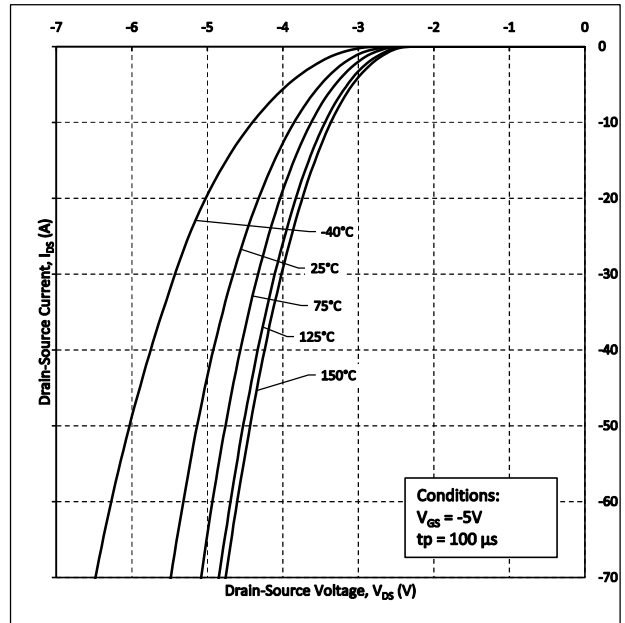


Figure 10. Body Diode Characteristics at  $V_{GS} = -5V$

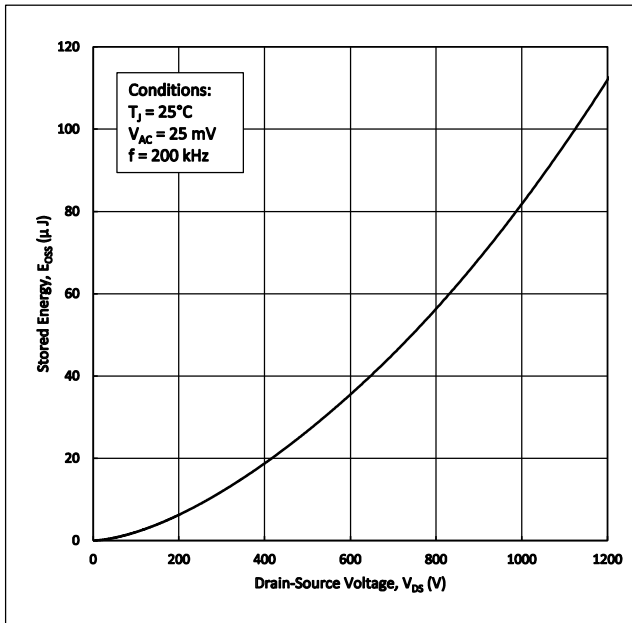


Figure 11. Output Capacitor Stored Energy

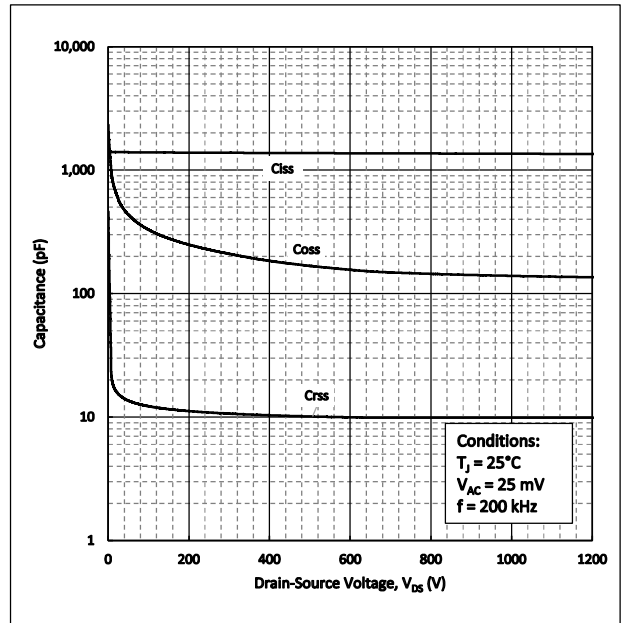


Figure 12. Capacitance vs. Drain-Source Voltage

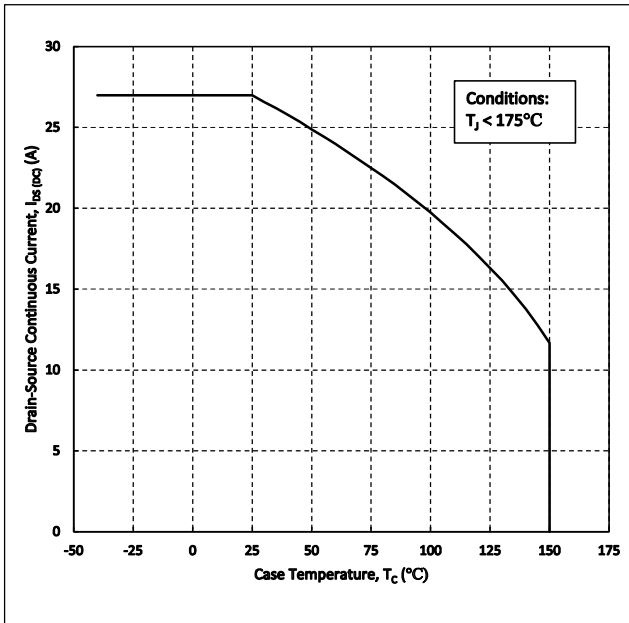


Figure 13. Continuous Drain Current Derating vs. Case Temperature

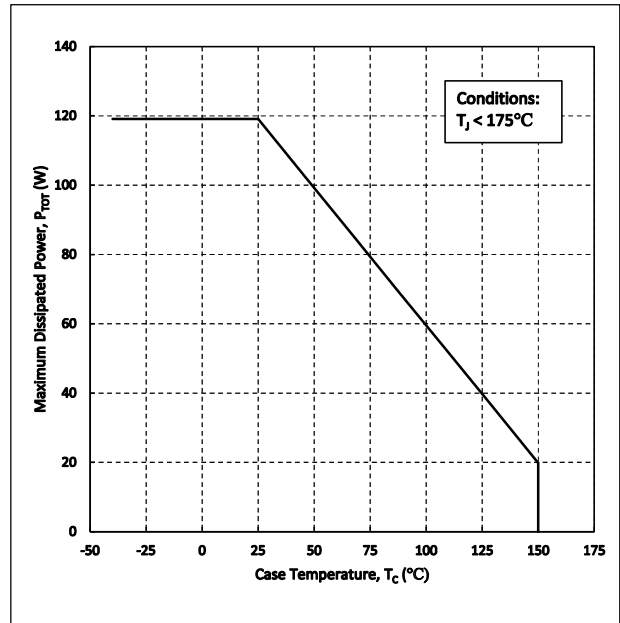


Figure 14. Maximum Power Dissipation Derating vs. Case Temperature

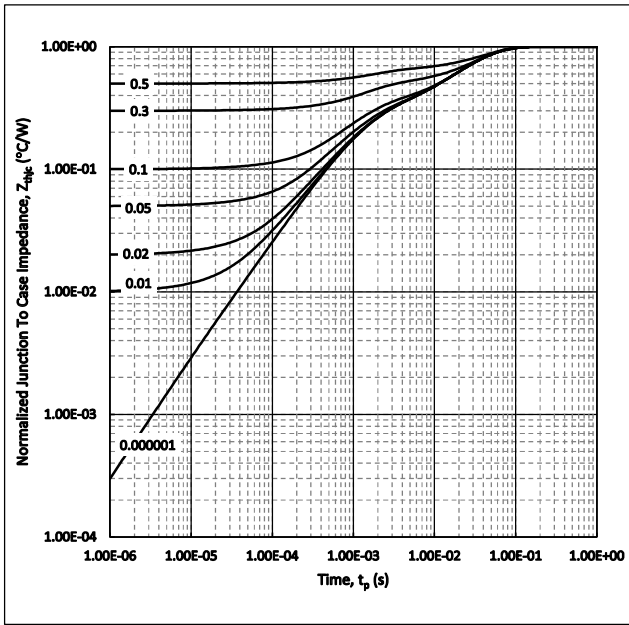


Figure 15. Transient Thermal impedance (Junction to Case)

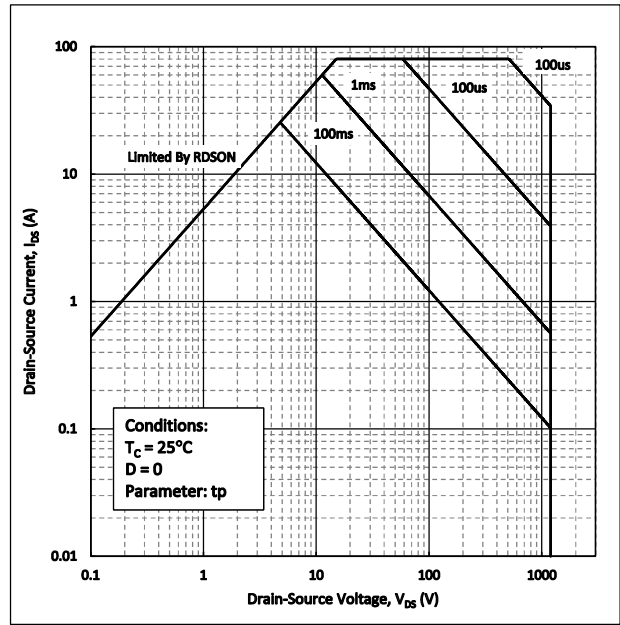


Figure 16. Safe Operating Area

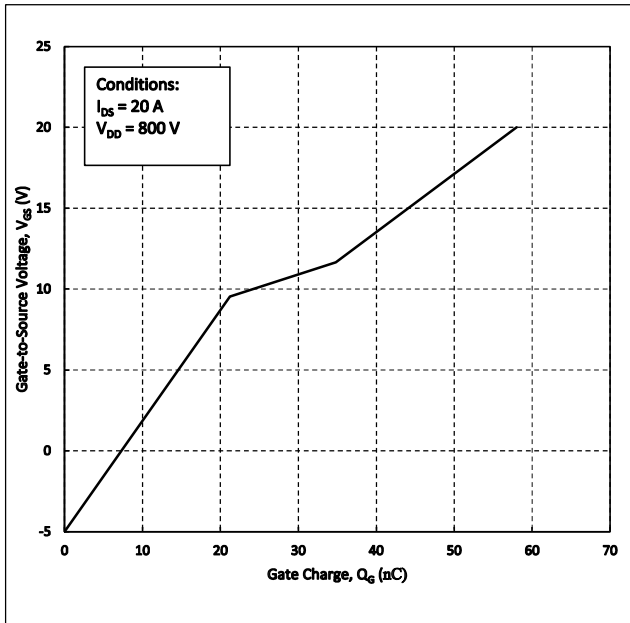


Figure 17. Gate Charge Characteristics

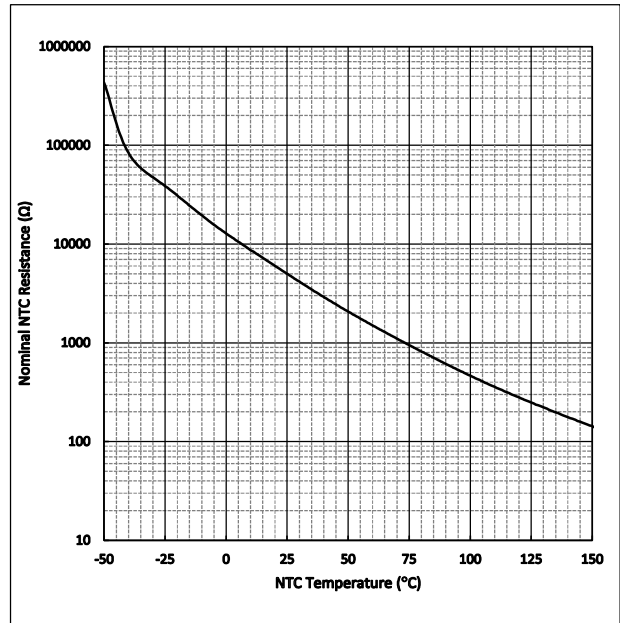


Figure 18. Nominal NTC Resistance vs. Temperature

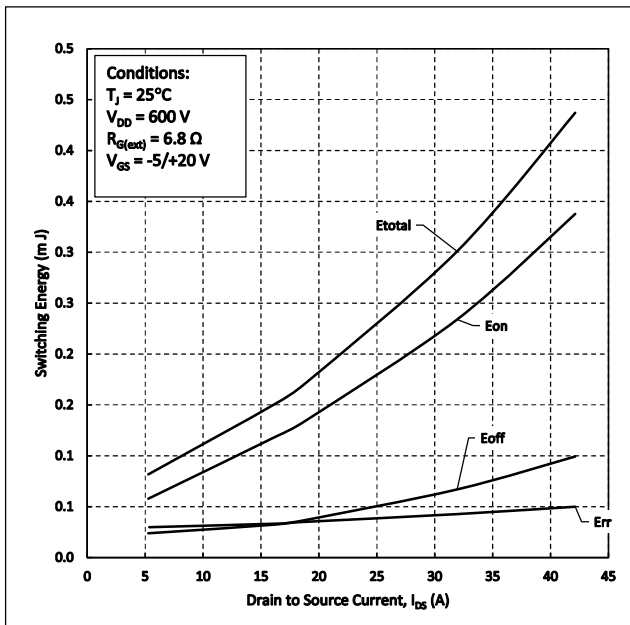


Figure 19. Clamped Inductive Switching Energy vs. Drain Current (600V)

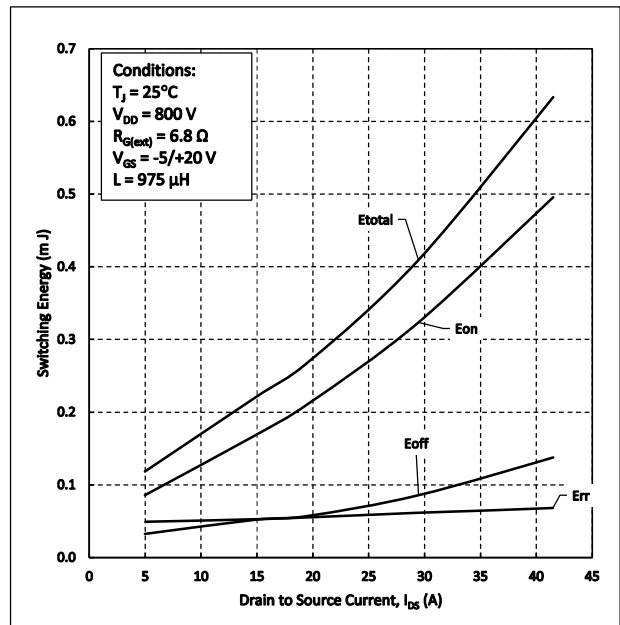


Figure 20. Clamped Inductive Switching Energy vs. Drain Current (800V)



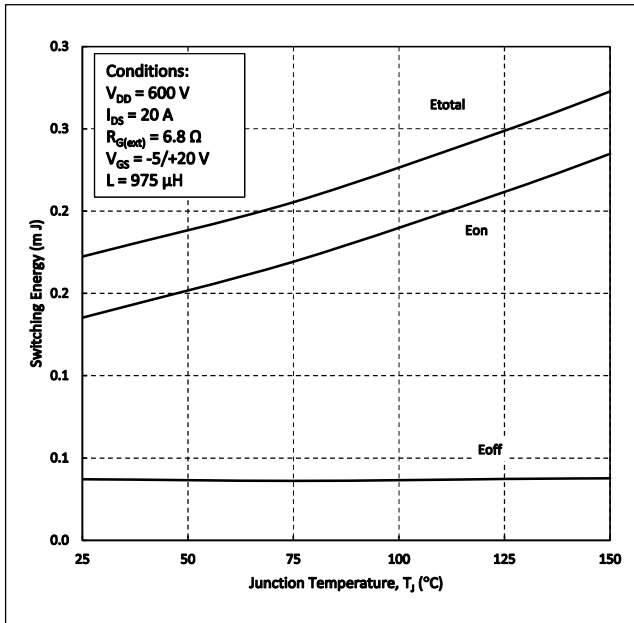


Figure 21. Clamped Inductive Switching Energy vs. Temperature

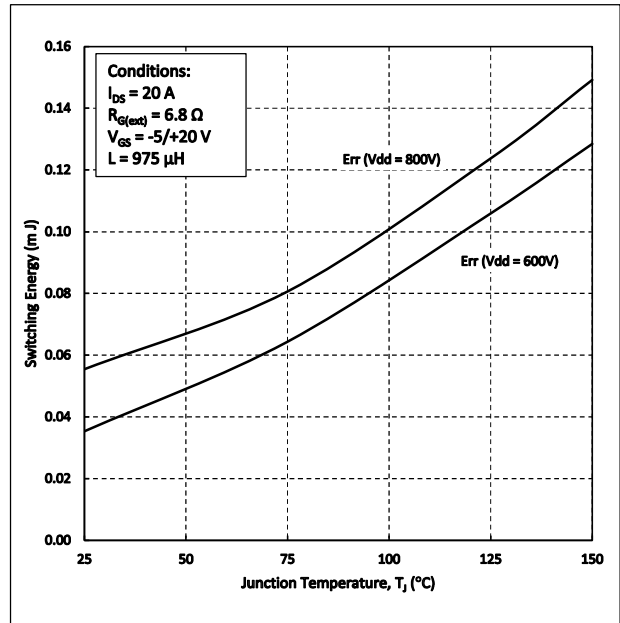


Figure 22. Reverse Recovery Energy vs. Temperature

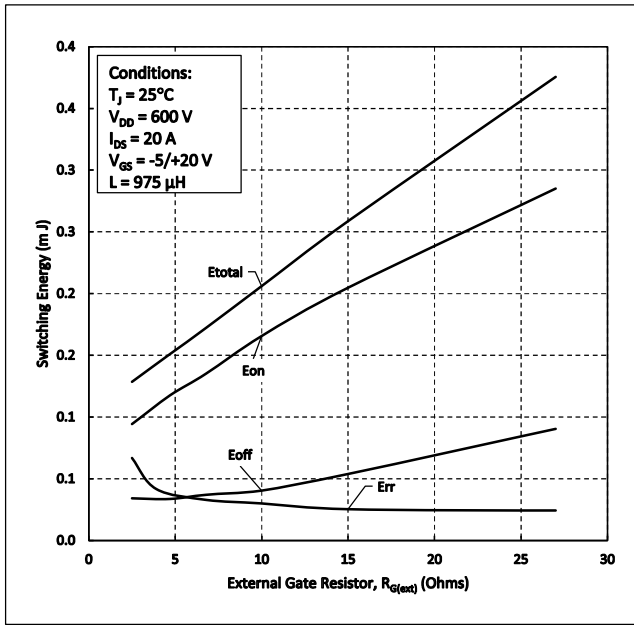


Figure 23. Clamped Inductive Switching Energy vs.  $R_{G(ext)}$

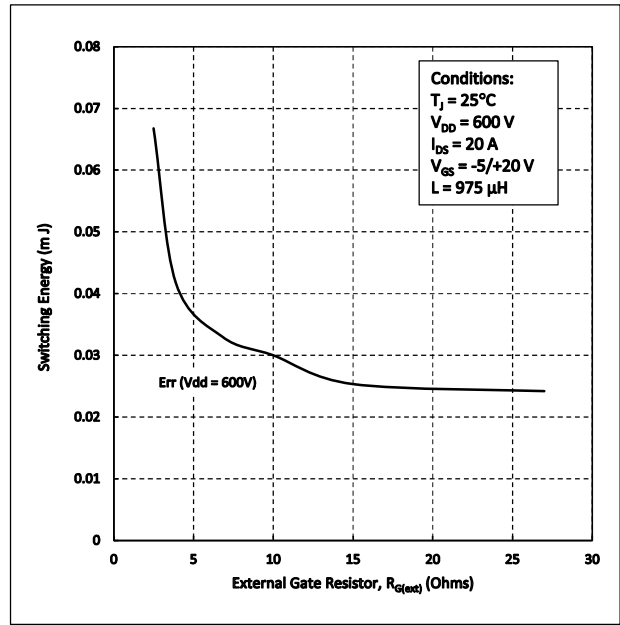


Figure 24. Reverse Recovery Energy vs.  $R_{G(ext)}$

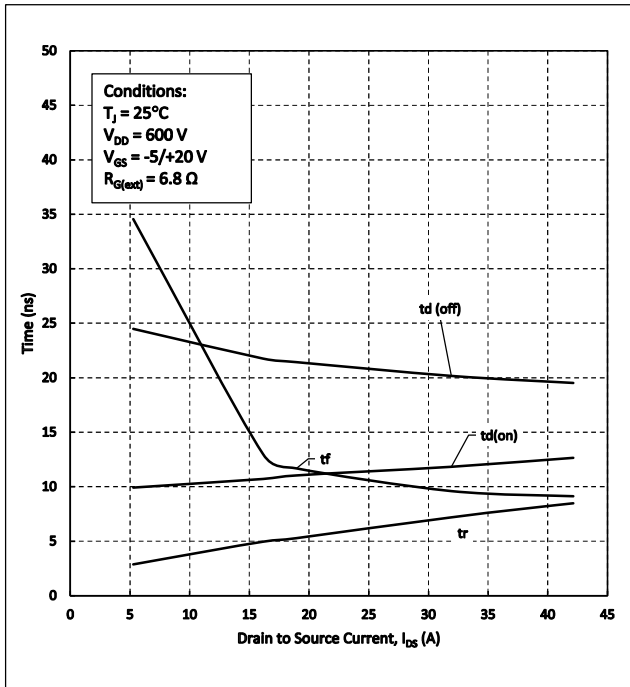


Figure 25. Switching Times vs. Drain Current

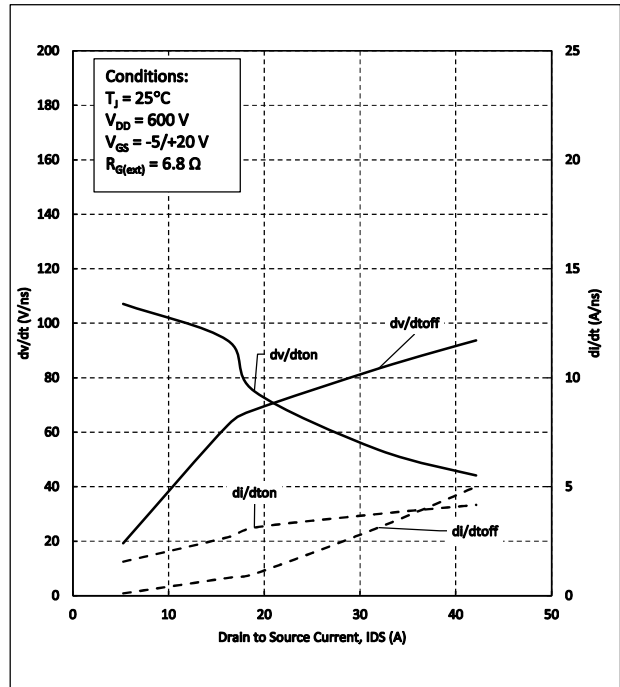


Figure 26.  $dv/dt$  and  $di/dt$  vs. Source Current

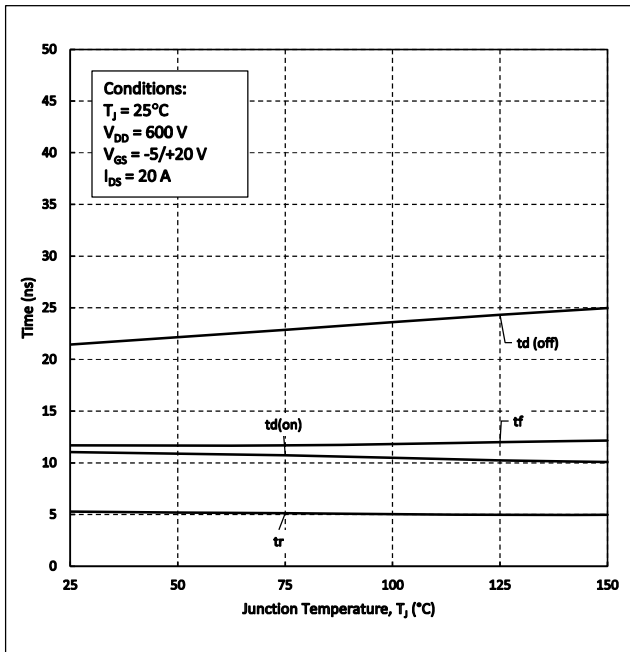


Figure 27. Switching Times vs. Temperature

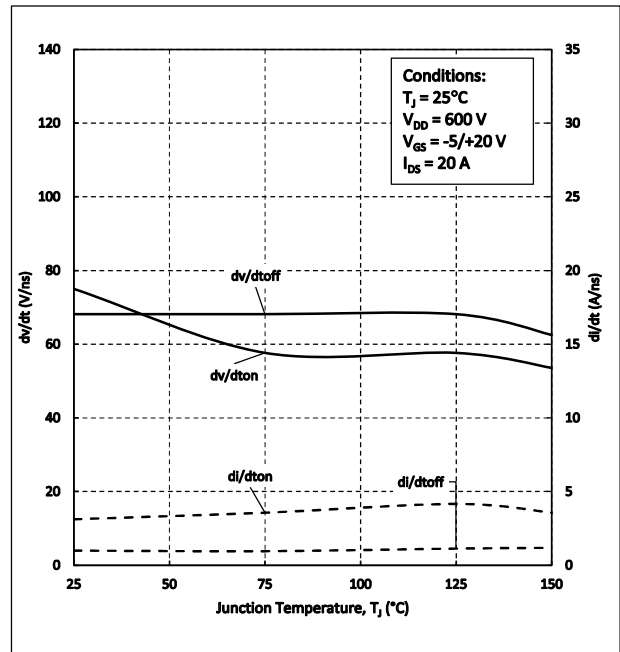


Figure 28.  $dv/dt$  and  $di/dt$  vs. Temperature

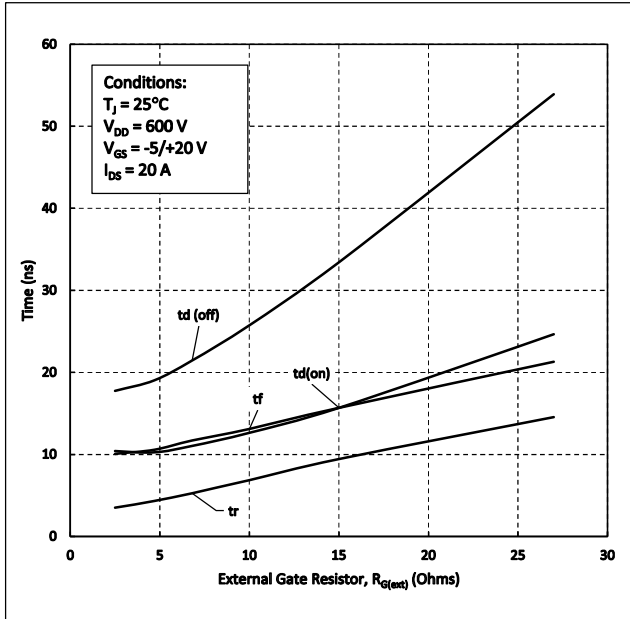


Figure 29. Switching Times vs.  $R_{G(ext)}$

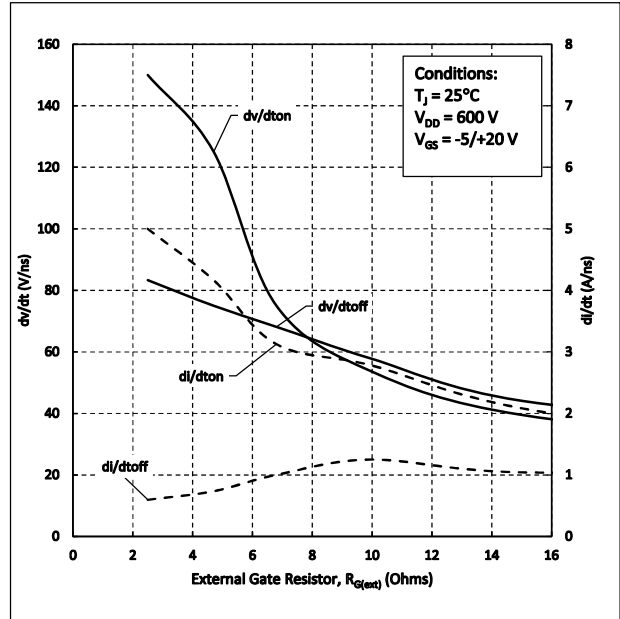


Figure 30.  $dv/dt$  and  $di/dt$  vs.  $R_{G(ext)}$

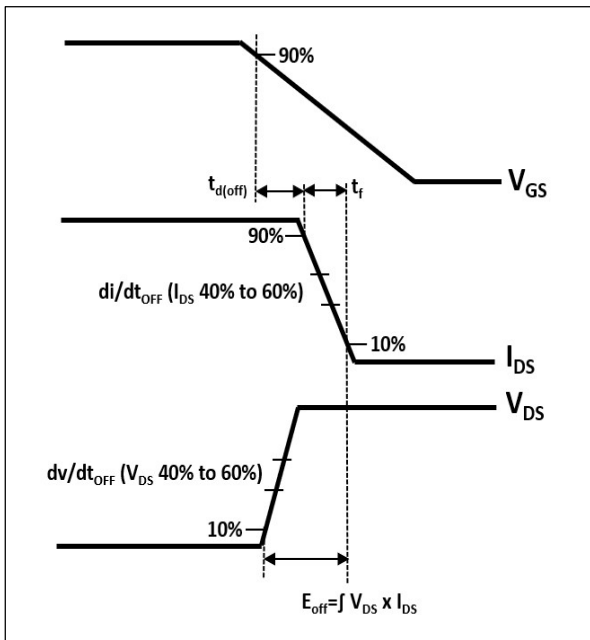


Figure 31. Turn-off Transient Definitions

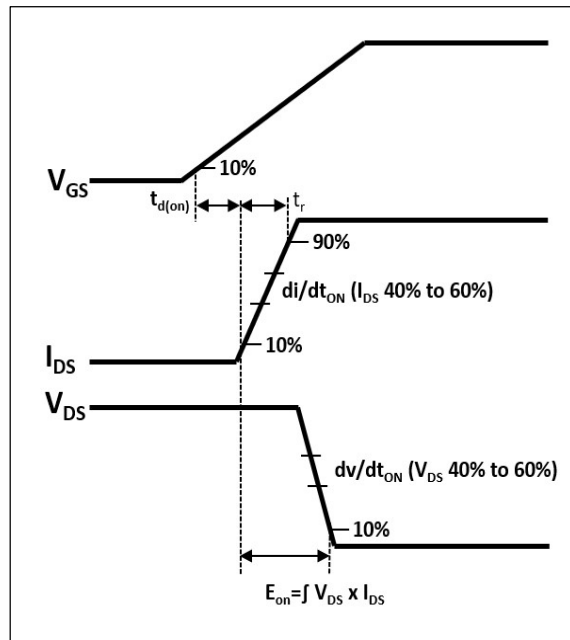


Figure 32. Turn-on Transient Definitions

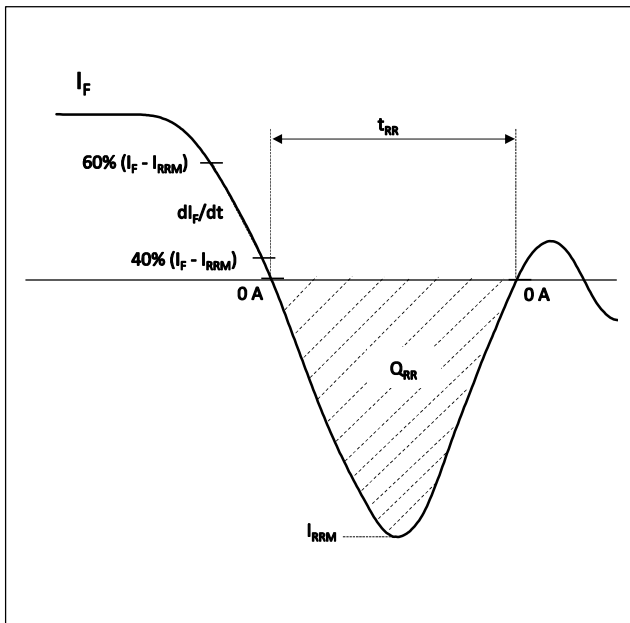
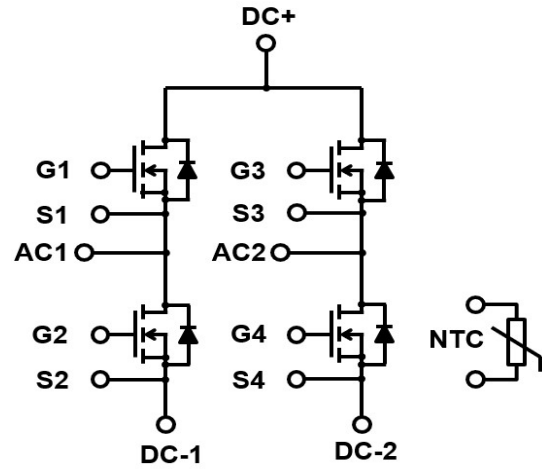
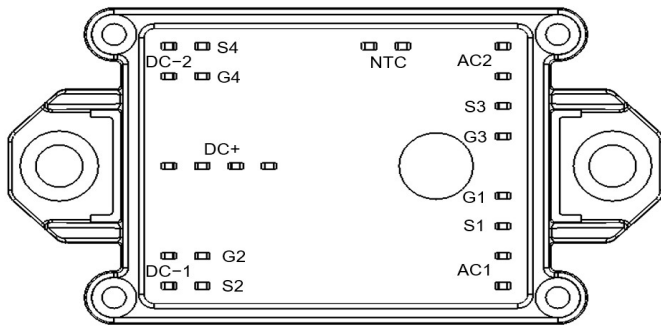


Figure 33. Reverse Recovery Definitions

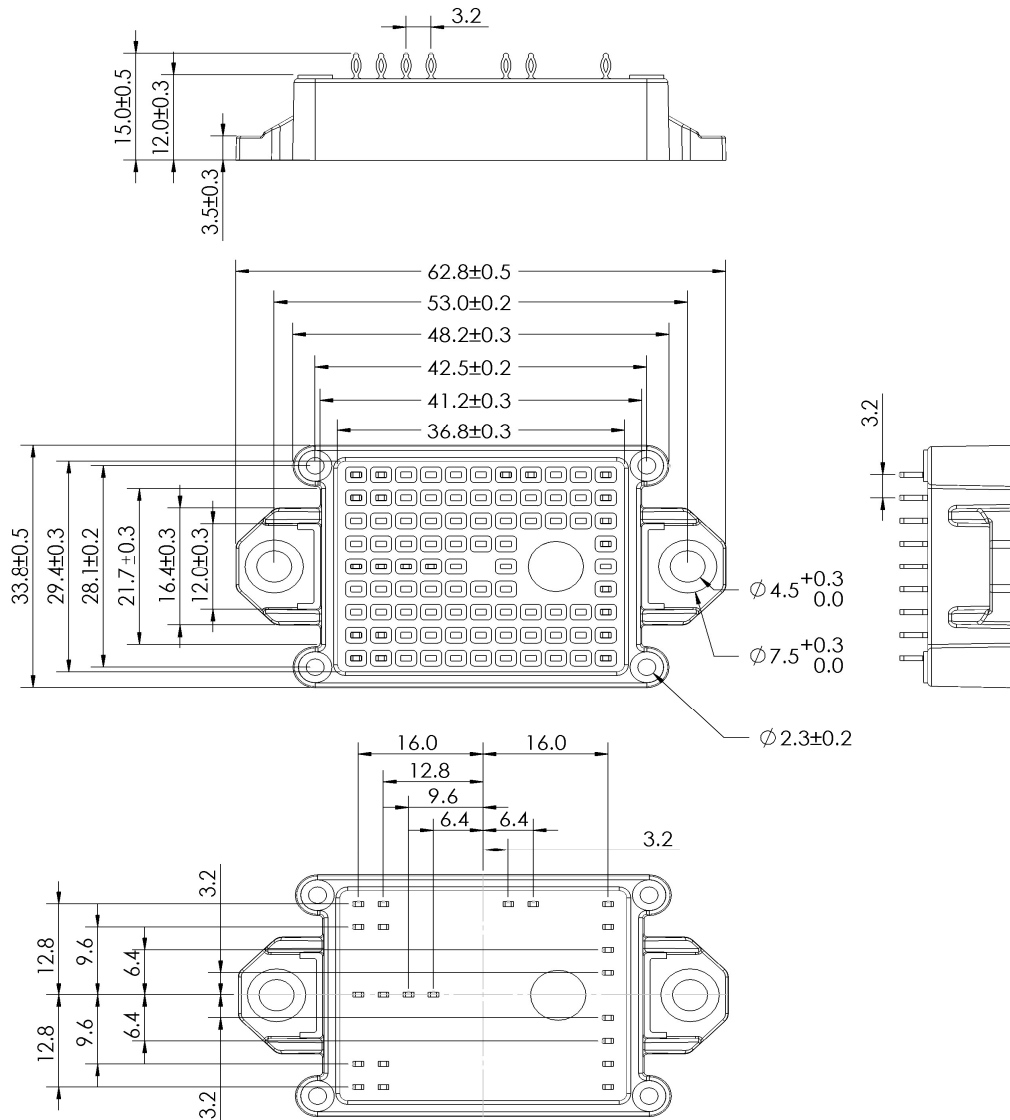
# QSiC™ 1200V SiC Full-Bridge Module

GCMX080A120B2H2P

## Pinout and Circuit Diagram



## Package Dimensions (mm) for B2



Revision History		
Date	Revision	Notes
11/26/2024	1.0	Initial Release

**Notes**

**RoHS Compliance**

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS2), as implemented March, 2013. RoHS Declarations for this product can be obtained from the Product Documentation sections of [www.SemiQ.com](http://www.SemiQ.com).

**REACH Compliance**

REACH substances of high concern (SVHC) information is available for this product. Since the European Chemicals Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact our office at SemiQ Headquarters in Lake Forest, California to insure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request.

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